



2332-20

School on Synchrotron and FEL Based Methods and their Multi-Disciplinary Applications

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Introduction to X-ray microscopy and spectro-microscopy

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Introduction to X-ray microscopy and spectro-microscopy





 Materials have properties varying at various depth and length scales. Structure and chemical composition usually is different at the surface and in the bulk. New properties expected with decreasing the dimensions stepping in nanoworld.

What we NEED:

Spatial resolution & chemical sensitivity, morphology & structure, varying probing depth, temporal resolution..

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Why using synchrotrons for microscopy?



Only 'LIGHT' with comparable wavelength, λ , can visualize the micro- and nano-structured world





X-Rays compared to charged particles:

- Higher penetration power: wavelenght controlled.
- > Great variety of spectroscopies-elemental, chemical etc information.
- > Variety of imaging contrasts with diffraction limited resolution.
- Less sensible to sample environment in photon-out detection mode.

Interactions of x-rays with the matter: redirection & <u>absorption ⇒ x-ray transmission</u> and x-ray or electron emission

elettre

aelettra





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X-ray focusing optics: zone plates, mirrors, capillaries





Zone Plate optics: from ~ 200 to ~ 10000 eV <u>Monochromatic:</u> <u>Resolution achieved 15 nm</u> <u>in transmission</u>



KP-B mirrors each focusing in one direction: soft & hard: ~ 1000 nm <u>Soft & hard ×-rays!</u> <u>achromatic</u> focal point, easy <u>energy</u> tunability, comfortable working distance Resolution ≤ 100 nm



Normal incidence: spherical mirrors with multilayer interference coating (Schwarzschild Objective) Monochromatic, good for <u>E < 100eV</u> <u>Resolution: best ~ 100 nm</u>



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Synchrotrons offer a variety of imaging approaches, based on x-ray absorption, scattering and spectroscopies





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Sampling depths depend on the detected signal (electrons or photons)





Fluorescence emission: Probe depth- > 100 nm = f(photon energy, matrix)



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Imaging and µ-spectroscopy



Illy coffee cells



Ni/Si-Ni3p map





<u>The image contrast based Emitted</u> <u>electrons (XPS,XANES),</u> <u>Transmitted/emitted photons</u> <u>(XANES,FS) can provide:</u>

> Morphology: density, thickness..

Element presence and concentration;

- > Chemical state;
- > Band-bending or charging;

> Magnetic spin or bond orientation.

<u>Microspectroscopy:</u> µ-XPS, µ-XANES, µ-XRF in selected areas from the images: detailed characterization of the chemical and electronic structure of coexisting micro-phases.

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X-ray transmission microscope (TXM-FFIM)



CCD

camera

FERMI Full-field X-ray imaging or "one shot" X-ray image acquisition can be considered as the optical analog to visible light transmission microscope

Günther Schmahl, 1st experiment DESY 1976



What we need?
a suited condenser system
a specimen stage (automated)
an eyepiece/camera

Objective ZP to magnify the image onto the detector

> Nikon Eclipse E200 Student Microscope

Specimen environment to be adapted to application

X-ray light

Condenser illuminating the object field: ZP, capillary

<u>2006 - XTM (7+4):</u> - ALS (2), SSRL (1), APS (2), BESSY II (1), ELETTRA (1), ESRF (1), ASTRID (1), SPRING'8 (1), AURORA (1), DIAMOND (1), SOLEIL (1), ALBA (1), SLS (1). Resolution achieved 15 nm.

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X-ray Scanning microscopy: uses focusing x-ray optics (preferred zone plates) Works in Transmission and Emission + spectroscopy from the spot





<u>STXM and/or SPEM (17):</u> - ALS (4), SSRL (1), APS (2), BESSY2 (1), ELETTRA (3), ESRF (1), PLS (1), NSLS (1), SLS (2), SPRING'8 (1), SRRC (1), CLS (1), DIAMOND (2), Soleil (1), NSLS-II (2) Resolution achieved 25 nm.

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Zone plate: circular diffraction grating of N lines with radially decreasing line width operating in transmission





Important parameters:

Finest zone width, dr. (10-100 nm) determines

the Rayleigh resolution (microprobe size) $\delta t=0.61 \lambda/(\theta) = 1.22 \delta r_N$ <u>Diameter, D (50-250 mm)</u> determines the focal distance f_m . Efficiency % of diffracted x-rays: 10-40% (4-25%) Monochromaticity required: $\lambda/d\lambda \ge N$ (increases with dr and D).

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Photon-in/photon-out microscopy versatile specimen environment – no requirement for UHV!





"Wet cell" environment for imaging of liquids (agglomeration, solidification, hydratation)

3D imaging environment: Stereo-imaging and tomography: FFI is the better choice



Operation in air, vacuum and inert gas atmosphere

Chemical reaction cell for catalysis experiments under normal conditions

> Magnetic cell for dichroism studies

Development of cryotechniques for for radiation sensitive specimen

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Computed tomography of Cu interconnects with the BESSY TXM



High resolution images of ICs after alignment (50 projections, 140°)









1 µm

G. Schneider et al., J. Vac. Sci. Technol. B 20, 3089 (2002) ICTP School March 19-30, 2012 Maya Kiskinova



Chemical mapping of interplanetary dust particles with STXM at ALS





Jupiter Family Comet 26P/Grigg-Skjellerup Interplanetary Dust Particle Sample I2054-E1-B Relating meteorites to the NASA Stardust Project



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Proton Exchange Membrane Fuel Cell (PEMFC) with in-situ soft X-ray micro-spectroscopy: metal electrode stability





water solution Nafion 0.25 %, isopropyl alcohol 3.75 %



STXM - LEXRF - XANES





Corrosion of Ni in 1-butyl-1-methyl-pyrrolidinium bis (trifluoromethylsulfonyl) amide room-temperature ionic liquid: operated at anodic polarization of 0.5 V vs Au electrode B. Bozzini et al, ChemPhysPhysChem (in press)







Ni corrosion products tend to interact with the RTIL within the zone close to the electrode, changing the Ni valence state. The localisation of the higher-valence form of oxidised Ni in the highcurrent density region is coherent with the higher anodic potentials developed there.

Metallic Plate Corrosion and Uptake of Corrosion Products by Nafion in Polymer Electrolyte Membrane Fuel Cells B. Bozzini et al, ChemSusChem 3, 1, 2010



Fe undergoes corrosion and diffuses in the Nafion, whereas the Ni electrode remains apparently intact.

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Hard X-ray SXM: lower resolution but XRF with depth and ppm sensitivity



 10^{5} 10^{2} → X-ray △E=E1-E0=Ka Element specific (no labelling) Ρ 1000 Co-localisation SCI 100 Low detection limit (trace Κ Mdd 10 element). Ca High signal-to-background ratio Mn Cu (low dose) 0.1 00 Zn Se Pb 0.01 15 $\dot{20}$ 25 10 30 35 40 Atomic number Z 1.0 0.9 K-shell > Penetration depth: > 50μ m 0.8 0.7 > All type of samples Fluorescence yield 0.6 \succ μ -XANES (S, P, K, Ca, Fe..) 0.5 0.4 in total fluorescence yield 0.3 L-shell (average) 0.2 0.1 0.0 20 40 60 80 100 120 Atomic number



TiO2-DNA nano-composites for in-vivo Gene Surgery: XRF maps





Chemical FS imaging is crucial to quantify the success rate and reveal the location of the single stranded nanoparticle in the cell chromosome

DNA-TiO2 particle crossing cell walls





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Determination of the Sb oxidation state in ancient glasses, opacified by the presence of Ca antimonate crystals: XANES in Total Fluorescence detection





ID21, ESRF

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X-ray contrast based on photon detection Bulk sensitive





More details for the FFIM and STXM + XRF techniques and applications in the forthcoming lectures of Alessandra Gianoncelli

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Low-dimensional materials and their unique properties



There's Plenty of Room at the Bottom

An Invitation to Enter a New Field of Physics & Material Science Richard P. Feynman - 1959!!!





Surface 'geometric' structure <u>Increased surface-to-volume ratio:</u> <u>the surface status controls physical</u> <u>and chemical properties</u>

Surface chemistry

Electronic properties and confinement effects

Spatial resolution with chemical and structural <u>surface</u> sensitivity are needed.

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All information of PES at microscopic scales f



- Qualitative and quantitative elemental information: CL
- Chemical composition and chemical bonding:CL & VB
- · Electronic and magnetic structure (VB, ARUPS, PED, XMCD-XMLD with secondary electrons (XANES).
- Information depth < 10 nm (surface sensitive)



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Synchrotron-based photoelectron microscopes: they are complementary



SPEM





circularly

XPEEM-LEEM





Forthcoming lecture: Andrea Locatelli

- + Full power of XPS
- + Spectro-imaging.
- + Flexible sample geometry and FOV.
- + Insensitive to sample roughness;
- Fast processes or XANES.
- Lateral resolution (50 nm)-

- + Lateral resolution (<5nm imaging)
- + Dynamic studies;
- + XANES, PED&ARUPS.
- + LEEM & m-LEED: structure
- XPS spectral resolution
- sample roughness and size.

Fe 719eV

 $-M^{\uparrow\uparrow}\sigma_{m}$



Layout of SPEM: ZP optics, sample and positioning systems











Spatial resolution in emission limited by the sample-to-optics distance ! $f_m = D_x dr_x E_{ph} / 1240$ $DOF = \frac{\delta r}{D} f_m$

Typical: 5-15 μm



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Multichannel detection in SPEM: each pixel = spectrum





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Catalysis-related research



single crystals, supported particles, modifiers and pattern formation

elett

FERMI @elettra

> New York Times: June 8, 1923 Catalysis, that strange principle of chemistry which works in ways more mysterious and inexplicable than almost any other of the many curious phenomena of science



What is the active catalyst state: can we describe it as a single phase?? Dynamic changes under reaction conditions (structural, chemical..)!!

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Model Ru(0001) and Rh(110) catalysts



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Oxidation states: Ru(Rh)3d maps & Ru(Rh)3d μ -PES



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The long-range ordered structures are not necessarily the ones working under conditions of high chemical potential and enabled structural dynamics. 'SPEM prompts complex Ru surface morphology but <u>in-situ AP-SPEM needed</u> <u>to prove it!</u>

R. Blume et al, Cat.Tod. & PCCP (2007); Book Chapter in Nanostructured Catalysis, RCS 2011

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Model catalyst system: Rh micro- and nanoparticles or nano-crystalline films



SPEM

Deposited by PLD on MgO

Complex & variable morphology :

- 1) 'Defined' (crystalline) or 'notdefined' structure;
- 2) Structural effects: relative concentration of unsaturated atoms is size dependent and affects the reactivity.
- 3) Relative number of constituent atoms in contact with the support is size dependent.
- 4) Electron confinement below ~ 5 nm.

Thin films are nano-crystalline





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Oxidation states within a single Rh micro-particle





Lateral inhomogeneity in the oxidation state; some 'aggregates' reach oxidation states (RhO₂) not observed with extended Rh samples.

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P. Dudin el al, JCP in press Kiskinova



Degradation of organic light emission devices mechanism revealed by SPEM





Chemical imaging & μ -XPS revealed anode material (In and Sn) deposited around the hole created in the Al cathode.

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'In-situ' imaging of the local deformation and fracturing of the OLED cathode surface during device operation in the SPEM



Operation time at 10-25 V



Lateral inhomogeneity of the surface topography and chemistry of the InSn oxide anode films suggested as the major reasons for the device failures.

P. Melpigniano et al, APL 86, 41105



Local decomposition of InSn oxide and organic layer, caused by spikes is evidenced by the spectra taken inside the hole.



CNTs oxidation: morphology and oxygen bonding configurations





Increasing of oxygen dose The consumption of the CNTs starts from the tips and correlates with the abundance of particular oxygenated functional groups.

The variations in the defect density and type between individual CNTs account for different consumption rates.

The continuous increase of the number of broken C-C bonds with advancing the gasification leads to non-linear consumption with increasing O dose.

SPEM characterization of MoS₂-nanotubes









SPEM revealed I (used as a carrier) in interstitial positions between the tubes bonded to the outer S atoms.

Due to the low dimensionality the S 2p, Mo 3d and VB spectra are positiondependent and reflect electronic properties significantly different those of the MoS₂ crystal.



Classical X-ray imaging and spectromicroscopy: brief outline



SURFACES & INTERFACES: XPEEM and SPEM

PHOTON IN/ ELECTRON OUT (probing depth= $f(E_{el})$ max ~ 20 nm)

Spectroscopy (XPS-AES-XANES) ONLY CONDUCTIVE SAMPLES

<u>Total e⁻ yield</u> (sample current) <u>XANES</u>

Chemical surface sensitivity:
 Quantitative μ-XPS (0.01 ML)
 Chemical & electronic (VB) structure

BULK SAMPLES STXM-SPEM-TXM

PHOTON IN/PHOTON OUT (probing depth = $f(E_{ph}) > 100 \text{ nm}$)

(Spectroscopy - XFS or XANES)

<u>Total hv yield.</u> <u>Transmitted x-rays</u>

Chemical bulk sensitivity Quantitative µ-XFS Trace element mapping

Imaging: spatial and temporal limitations

Classical XRM (scanning & full field): (1) <u>limited in resolution</u> and focal depth by the optical elements; (2) morphology evolution of non-periodic systems > ms; (3) radiation damage: serious issue.

The optics depth and spatial resolution limitations can be overcome by image reconstruction from measured <u>coherent</u> X ray scattering pattern visualizing the electron density of non-crystalline sample.



aelettra

The temporal resolution can go to a few fs range, beating the radiation damage by single-shot imaging..

Lectures Kirz-Chapman

catte







Infrared Specromicroscopy: microprobe – apertures (diffraction limited)





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Chemical specificity and resolution using SR





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Enjoy the following Lectures



X-ray microscopy: absorption & phase contrast (lecture Gianoncelli) · 2D/3D morphology

- High resolution.
- Density mapping.

X-ray (Coherent) Scattering (lectures Kirz-Chapman) •Structure: stress/strain/texture 2D/3D mapping. • Chemistry at resonances

> Fluorescence spectromicroscopy (lecture Gianoncelli) • Elemental quantification • Elemental mapping • Bulk sensitive

Photoelectron imaging and Spectromicroscopy: (lecture: Locatelli) • Chemical state

- Chemical and magnetic mapping.
 - Surface sensitive.

Infrared Spectromicroscopy (lecture Vaccari)

Molecular groups and structure
High S/N for organic matter
Functional group imaging.
Modest resolution but non-destructive radiation.

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